

Notice of References Cited	Application/Control No. 10/533,063		Applicant(s)/Patent Under Reexamination SHORT ET AL.	
	Examiner DENNIS HEYER		Art Unit 4121	Page 1 of 1

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*	B	US-4,865,870	09-1989	Hu et al.	427/2.1
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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